Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/743,931	JUNG ET AL.
Examiner	Art Unit

Djenane M. Bayard

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	SEARCHED		
Class	Subclass	Date	Examiner
709	224	6/20/2007	DB
709	223	6/20/2007	
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Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAF		SY)
	DATE	EXMR
east	6/20/2007	DB
Double Patenting search	6/20/2007	DB
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